

Abstracts

A New Criterion for Linear 2-Port Stability Using a Single Geometrically Derived Parameter

M.L. Edwards and J.H. Sinsky. "A New Criterion for Linear 2-Port Stability Using a Single Geometrically Derived Parameter." 1992 Transactions on Microwave Theory and Techniques 40.12 (Dec. 1992 [T-MTT] (1992 Symposium Issue)): 2303-2311.

A new stability parameter " $\mu(S)$ ", is defined for linear 2-port circuits using a geometrical approach.

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